

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket No. 20228-0013US1	Application No. 10/580,698
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Damian Fiolka et al.	
		Filing Date November 29, 2006	Group Art Unit 2872

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/J.C./	115	Copy of International Search Report for International Application No. PCT/EP05/050981, dated July 28, 2005.
/J.C./	116	Copy of International Preliminary Report on Patentability for International Application No. PCT/EP05/050981, dated November 29, 2006
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